



FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office List of Documents Cited by Applicant						Attorney Docket No.: 1406-158		Serial No.: 10/634,242	
				Applicant(s): Hedler et al.					
				Filing Date: August 5, 2003				Group:	
U.S. PATENT DOCUMENTS									
Examiner Initial	No.	Document Number	Date	Name	Class	Subclass	Filing date if Appropriate		
<i>ML</i>	01	5,449,955	09/12/95	Debiec et al.			<hr style="width: 100%;"/>		
FOREIGN PATENT DOCUMENTS									
		Document Number	Date	Country	Name of Patentee or Applicant		Translation Yes No		
<i>ML</i>	1B	198 109 073	9/16/99	DE	Schmidt, Ralf		No		
<i>ML</i>	2B	197 12 219	10/01/98	DE	Hauer et al.		No		
<i>ML</i>	3B	695 00 388	10/23/97	DE	Debiec et al.		No		
<i>ML</i>	4B	40 22 545	01/23/92	DE	Smola et al.		No		
<i>ML</i>	5B	01257340	10/13/89	JAPAN	Nanbu Tetsuji		Yes		
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)									

EXAMINER

DATE CONSIDERED

*Examiner Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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		Document Number	Date	Country	Name of Patentee or Applicant		Translation Yes No
	1.	JP 2000 100821 A	07/04/2000	Japan	NEC Corp.		Yes (Abstract Only)
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							

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